TOSHIBA Field Effect Transistor Silicon P/N Channel MOS Type (P Channel U-MOSII/N Channel U-MOSII)

PC8403

Motor Drive Applications

Notebook PC Applications

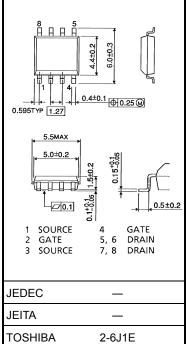
Portable Equipment Applications

- Low drain-source ON resistance: P Channel RDS (ON) = 45 m Ω (typ.) •
- N Channel RDS (ON) = $25 \text{ m}\Omega$ (typ.) High forward transfer admittance: P Channel $|Y_{fs}| = 6.2 \text{ S}$ (typ.) •
 - N Channel $|Y_{fs}| = 7.8 \text{ S (typ.)}$
- Low leakage current: •

- P Channel IDSS = $-10 \mu A (VDS = -30 V)$ N Channel IDSS = $10 \mu A (VDS = 30 V)$
- Enhancement mode
 - : P Channel V_{th} = -1.0~-2.2 V (V_{DS} = -10 V, I_D = -1 mA)
 - : N Channel V_{th} = 1.3~2.5 V (V_{DS} = 10 V, I_D = 1 mA)

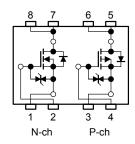
Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rat	Unit		
U	Symbol	P Channel	N Channel	Unit		
Drain-source voltage		V _{DSS}	-30	30	V	
Drain-gate vol	Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)			30	V	
Gate-source v	oltage	V _{GSS}	±20	±20	V	
Drain current	DC (Note 1)	ID	-4.5	6	А	
Drain current	Pulse (Note 1)	I _{DP}	-18	24	C	
Drain power dissipation	Single-device operation (Note 3a)	P _{D(1)}	1.5	1.5	W	
(t = 10s) (Note 2a)	Single-device value at dual operation (Note 3b)	P _{D(2)}	1.1	1.1		
Drain power dissipation (t = 10s) (Note 2b)	Single-device operation (Note 3a)	P _{D(1)}	0.75	0.75		
	Single-device value at dual operation (Note 3b)	P _{D(2)}	0.45	0.45		
Single pulse avalanche energy		E _{AS}	26.3 (Note 4a)	46.8 (Note 4b)	mJ	
Avalanche current		I _{AR}	-4.5	6	А	
Repetitive avalanche energy Single-device value at operation (Note 2a, 3b, 5)		E _{AR}	0.11		mJ	
Channel temperature		T _{ch}	150		°C	
Storage tempe	Storage temperature range			-55~150		



Weight: 0.080 g (typ.)

Circuit Configuration



Note 1, Note 2ab, Note 3ab, Note 4and Note 5: See the next page.

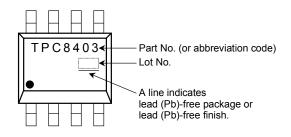
This transistor is an electrostatic-sensitive device. Please handle with caution.

Unit: mm

Thermal Characteristics

Characteristics	Symbol	Max	Unit		
Thermal resistance, channel to ambient (t = 10s) (Note 2a)	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	83.3		
	Single-device value at dual operation (Note 3b)	Rth (ch-a) (2) 114		°C/W	
Thermal resistance, channel to ambient	Single-device operation (Note 2a)	R _{th (ch-a) (1)}	167	0,111	
Thermal resistance, channel to ambient (t = 10s) (Note 2b)	Single-device value at dual operation (Note 2b)	R _{th (ch-a) (2)}	278	ſ	

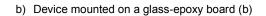
Marking



Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:

a) Device mounted on a glass-epoxy board (a)





Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.).
- b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.).

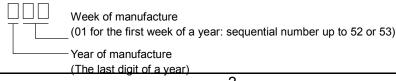
Note 4:

a) $V_{DD} = -24$ V, $T_{ch} = 25^{\circ}C$ (Initial), L = 1.0 mH, $R_G = 25 \Omega$, $I_{AR} = -4.5$ A

b) $V_{DD} = 24 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$ (Initial), L = 1.0 mH, R_G = 25 Ω , I_{AR} = 6.0 A

Note 5: Repetitive rating: pulse width limited by maximum channel temperature

- Note 6: on lower left of the marking indicates Pin 1.
 - Weekly code: (Three digits)



P-channel

Electrical Characteristics (Ta = 25°C)

Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS}=\pm 16~V,~V_{DS}=0~V$			±10	μA
Drain cut-OFF cu	irrent	I _{DSS}	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	_		-10	μA
Drain-source breakdown voltage		V (BR) DSS	$I_D = -10$ mA, $V_{GS} = 0$ V $I_D = -10$ mA, $V_{GS} = 20$ V	-30		_	v
		V (BR) DSX		-15	_	_	
Gate threshold vo	oltage	V _{th}	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -1 \text{ mA}$	-1.0		-2.2	V
Drain-source ON	registeres	D	$V_{GS} = -4.5 \text{ V}, I_D = -2.2 \text{ A}$	_	66	90	mΩ
Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -2.2 \text{ A}$	_	45	55	
Forward transfer	admittance	Y _{fs}	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -2.2 \text{ A}$	3.1	6.2		S
Input capacitance		C _{iss}	$V_{DS} = -10 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		940		pF
Reverse transfer capacitance		C _{rss}		_	270		
Output capacitance		C _{oss}		_	390		
	Rise time	tr	$V_{GS} \stackrel{0}{} V \stackrel{1}{} I_{D} = -2.2 \text{ A}$ $V_{GS} \stackrel{0}{} V \stackrel{1}{} V \stackrel{1}{} V_{OUT}$ $\stackrel{0}{} \stackrel{0}{} V_{OUT} \stackrel{1}{} R_{L} = 6.8 \Omega$ $\stackrel{0}{} V_{DD} \simeq -15 \text{ V}$		13	_	ns
Switching time	Turn-ON time	t _{on}			21	_	
Switching time	Fall time	t _f		_	25	_	
	Turn-OFF time	t _{off}	Duty $\leq 1\%$, t _w = 10 μ s	_	73	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq -24$ V, $V_{GS} = -10$ V, $I_D = -4.5$ A		18	_	nC
Gate-source charge 1		Q _{gs} 1			4		
Gate-drain ("miller") charge		Q _{gd}			4		

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	—	—	_	-18	А
Forward voltage (diode)		V _{DSF}	$I_{DR} = -4.5 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$	_	_	1.2	V

N-channel

Electrical Characteristics (Ta = 25°C)

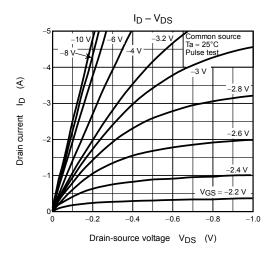
Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 16 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Drain cut-OFF current		I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	_		10	μA
Drain-source breakdown voltage		V (BR) DSS	$I_{D} = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	30	_	_	v
		V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	15		_	v
Gate threshold vo	oltage	V _{th}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	1.3		2.5	V
	resistance	Pro (ou)	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 3 \text{ A}$		38	46	
Drain-source ON resistance		R _{DS (ON)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3 \text{ A}$	_	25	33	mΩ
Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 3 \text{ A}$	3.9	7.8	_	S
Input capacitance		C _{iss}		_	850		pF
Reverse transfer capacitance		C _{rss}	V_{DS} = 10 V, V_{GS} = 0 V, f = 1 MHz	_	180		
Output capacitance		C _{oss}		_	270		
Switching time	Rise time	tr	$V_{GS} \begin{array}{c} 10 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} I_D = 3.0 \text{ A} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \end{array} \end{array}{$		11	_	ns
	Turn-ON time	t _{on}			18	_	
	Fall time	t _f			6.5	_	
	Turn-OFF time	t _{off}	Duty \leq 1%, t _w = 10 µs	_	27	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 24 \text{ V}, \text{ V}_{GS} = 10 \text{ V},$ $I_{D} = 6 \text{ A}$	_	17	_	
Gate-source charge 1		Q _{gs} 1		_	3	_	nC
Gate-drain ("miller") charge		Q _{gd}		_	4	—	

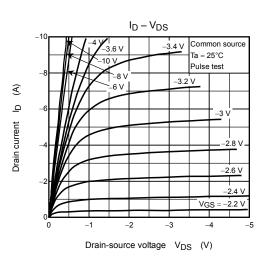
Source-Drain Ratings and Characteristics (Ta = 25°C)

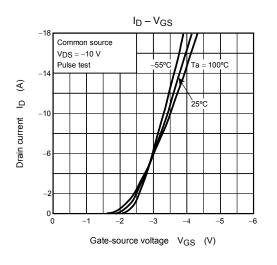
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	—	_	_	24	А
Forward voltage (diode)		V _{DSF}	$I_{DR} = 6 \text{ A}, V_{GS} = 0 \text{ V}$		_	-1.2	V

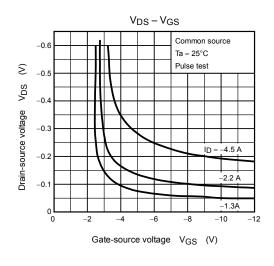
<u>TOSHIBA</u>

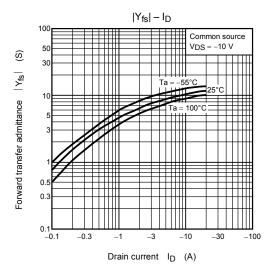
P-channel

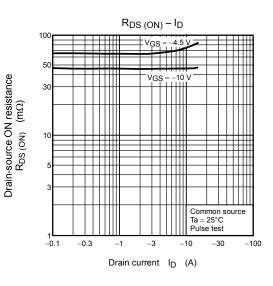




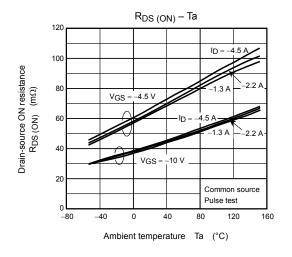


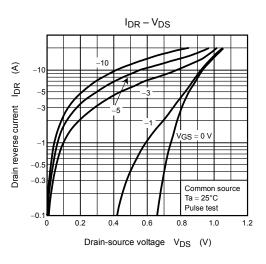


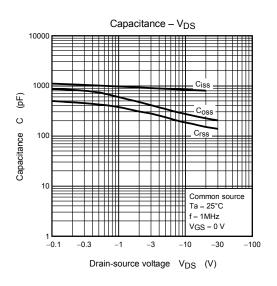


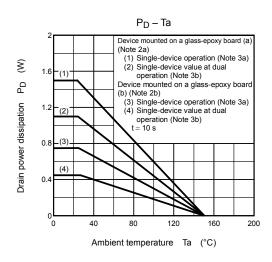


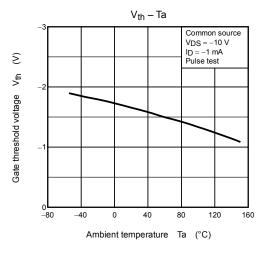
P-channel

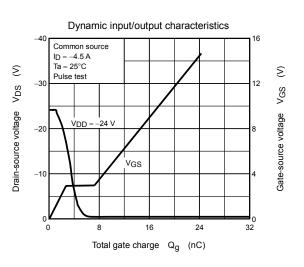












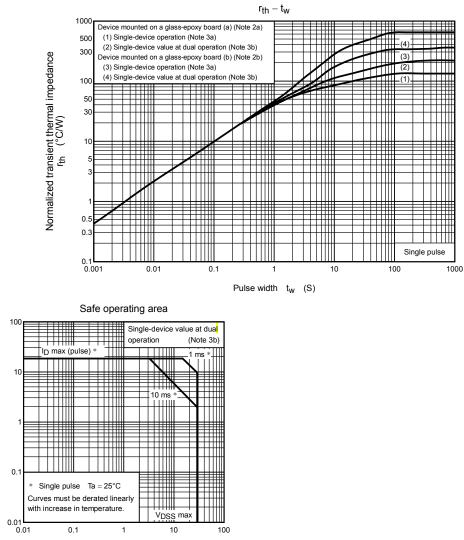
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P-channel

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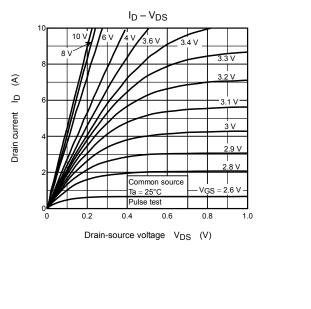
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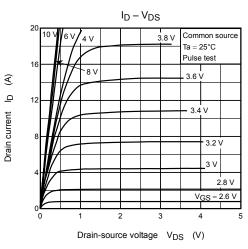
Drain current

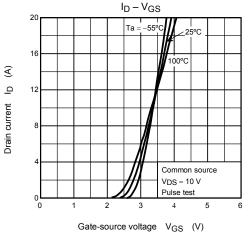


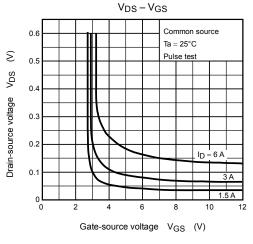
Drain-source voltage VDS (V)

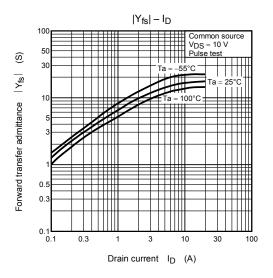
N-channel

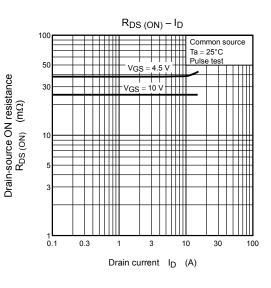




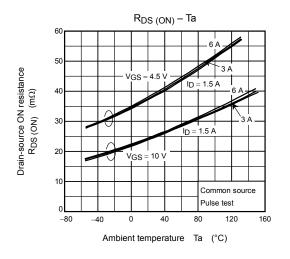


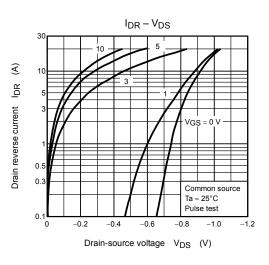


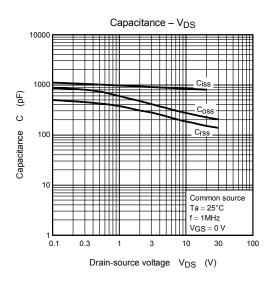


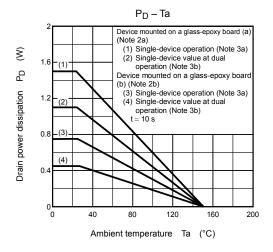


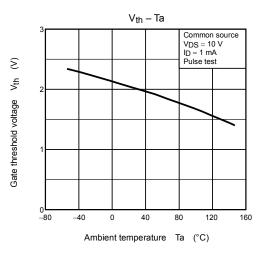
N-channel

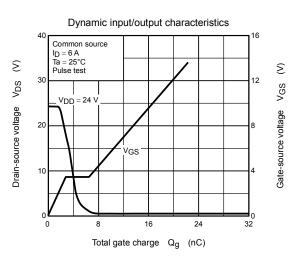












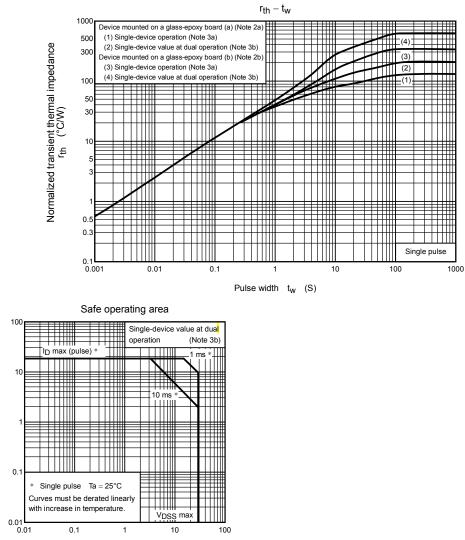
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N-channel

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Drain current



Drain-source voltage VDS (V)

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